

<b>Notice of References Cited</b>		Application/Control No. 10/594,708	Applicant(s)/Patent Under Reexamination LEE ET AL.	
		Examiner ROBERT CABRAL	Art Unit 1618	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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**FOREIGN PATENT DOCUMENTS**

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	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	U	Ishikawa et al., "Structure and electrical properties of Au <sub>2</sub> S," Solid State Ionics 79 (1995) 60-66		
	V			
	W			
	X			

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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